



AAT8543 20V P-Channel Power MOSFET

General Description

The AAT8543 is a low threshold MOSFET designed for the battery, cell phone, and PDA markets. Using AnalogicTech™'s ultra high density MOSFET process and space saving small outline J-lead package, performance superior to that normally found in a TSOP-6 footprint has been squeezed into the footprint of a SC70 package.

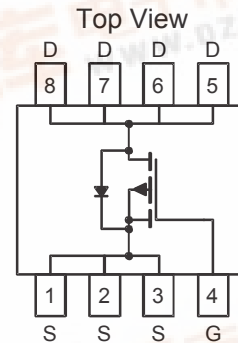
Features

- $V_{DS(MAX)} = -20V$
- $I_{D(MAX)}^1 = -4.2A @ 25^{\circ}C$
- Low $R_{DS(ON)}$:
 - $57 m\Omega @ V_{GS} = -4.5V$
 - $104 m\Omega @ V_{GS} = -2.5V$

Applications

- Battery Packs
- Cellular & Cordless Telephones
- Battery-powered portable equipment

SC70JW-8 Package



Absolute Maximum Ratings ($T_A=25^{\circ}C$ unless otherwise noted)

Symbol	Description	Value	Units
V_{DS}	Drain-Source Voltage	-20	V
V_{GS}	Gate-Source Voltage	± 12	
I_D	Continuous Drain Current @ $T_J=150^{\circ}C$ ¹	$T_A = 25^{\circ}C$ ± 4.2 $T_A = 70^{\circ}C$ ± 3.3	A
I_{DM}	Pulsed Drain Current ²	± 20	
I_S	Continuous Source Current (Source-Drain Diode) ¹	-1.2	
P_D	Maximum Power Dissipation ¹	$T_A = 25^{\circ}C$ 1.6 $T_A = 70^{\circ}C$ 1.0	W
T_J, T_{STG}	Operating Junction and Storage Temperature Range	-55 to 150	
			$^{\circ}C$

Thermal Characteristics

Symbol	Description	Typ	Max	Units
$R_{\theta JA}$	Typical Junction-to-Ambient steady state ¹	100	124	$^{\circ}C/W$
$R_{\theta JA2}$	Maximum Junction-to-Ambient $t < 5$ seconds ¹	62	76	$^{\circ}C/W$
$R_{\theta JF}$	Typical Junction-to-Foot ¹	35	42	$^{\circ}C/W$

Preliminary Information

Electrical Characteristics ($T_J=25^{\circ}\text{C}$ unless otherwise noted)

Symbol	Description	Conditions	Min	Typ	Max	Units
DC Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =-250μA	-20			V
R _{DS(ON)}	Drain-Source ON-Resistance ²	V _{GS} =-4.5V, I _D =-4.2A		45	57	mΩ
		V _{GS} =-2.5V, I _D =-3.1A		80	104	
I _{D(ON)}	On-State Drain Current ³	V _{GS} =-4.5V, V _{DS} =-5V (Pulsed)	-20			A
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =-250μA	-0.6			V
I _{GSS}	Gate-Body Leakage Current	V _{GS} =±12V, V _{DS} =0V			±100	nA
I _{DSS}	Drain Source Leakage Current	V _{GS} =0V, V _{DS} =-20V			-1	μA
		V _{GS} =0V, V _{DS} =-16V, T _J =70°C ³			-5	
g _{fs}	Forward Transconductance ²	V _{DS} =-5V, I _D =-4.2A		7		S
Dynamic Characteristics ³						
Q _G	Total Gate Charge	V _{DS} =-10V, R _D =2.4Ω, V _{GS} =-4.5V		8.5		nC
Q _{GS}	Gate-Source Charge	V _{DS} =-10V, R _D =2.4Ω, V _{GS} =-4.5V		1.5		
Q _{GD}	Gate-Drain Charge	V _{DS} =-10V, R _D =2.4Ω, V _{GS} =-4.5V		2.8		
t _{D(ON)}	Turn-ON Delay	V _{DS} =-10V, R _D =2.4Ω, V _{GS} =-4.5V, R _G =6Ω		10		ns
t _R	Turn-ON Rise Time	V _{DS} =-10V, R _D =2.4Ω, V _{GS} =-4.5V, R _G =6Ω		32		
t _{D(OFF)}	Turn-OFF Delay	V _{DS} =-10V, R _D =2.4Ω, V _{GS} =-4.5V, R _G =6Ω		61		
t _F	Turn-OFF Fall Time	V _{DS} =-10V, R _D =2.4Ω, V _{GS} =-4.5V, R _G =6Ω		38		
Source-Drain Diode Characteristics						
V _{SD}	Source-Drain Forward Voltage ²	V _{GS} =0, I _S =-4.2A			-1.3	V
I _S	Continuous Diode Current ¹				-1.2	A

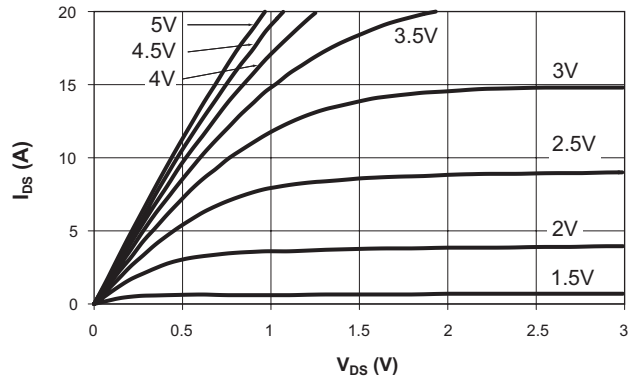
Notes:

- Based on thermal dissipation from junction to ambient while mounted on a 1" x 1" PCB with optimized layout. A 5 second pulse on a 1" x 1" PCB approximates testing a device mounted on a large multi-layer PCB as in most applications. $R_{\theta JF} + R_{\theta FA} = R_{\theta JA}$ where the foot thermal reference is defined as the normal solder mounting surface of the device's leads. $R_{\theta JF}$ is guaranteed by design, however $R_{\theta CA}$ is determined by the PCB design. Actual maximum continuous current is limited by the application's design.
- Pulse test: Pulse Width = 300 μs
- Guaranteed by design. Not subject to production testing.

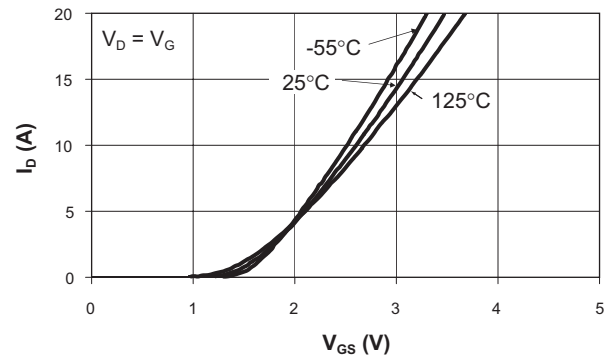
Typical Characteristics

($T_J = 25^\circ\text{C}$ unless otherwise noted)

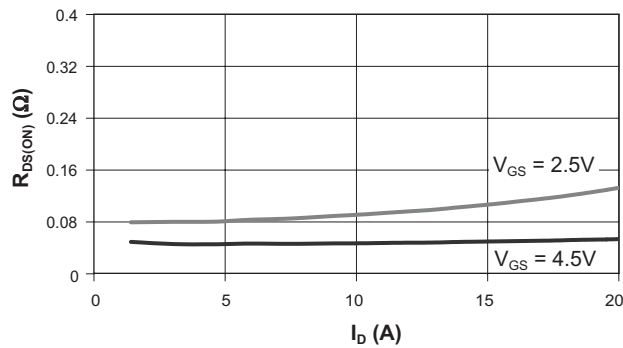
Output Characteristics



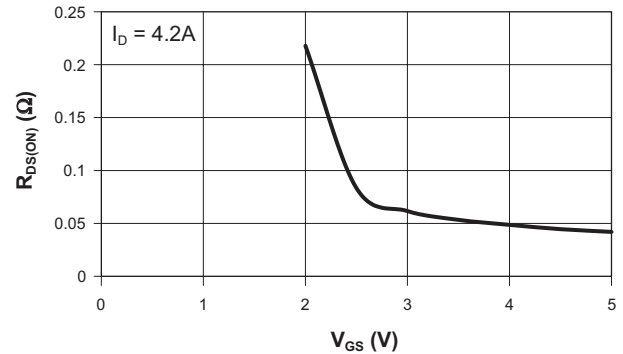
Transfer Characteristics



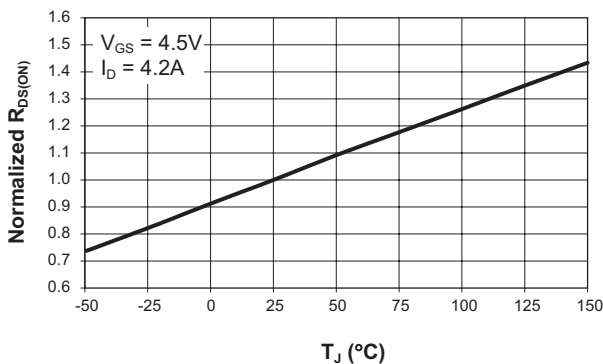
On-Resistance vs. Drain Current



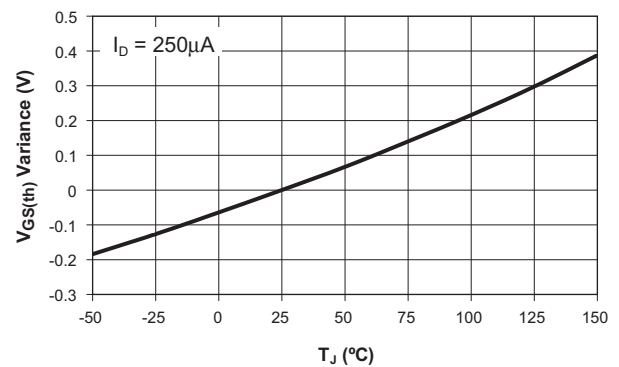
On-Resistance vs. Gate to Source Voltage



On-Resistance vs. Junction Temperature



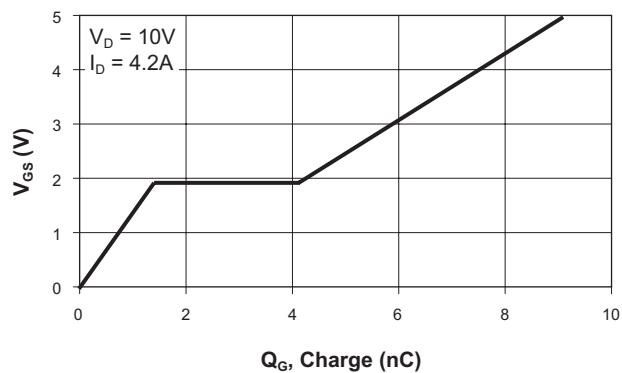
Threshold Voltage



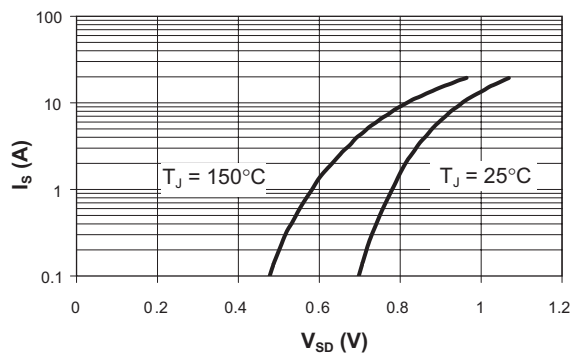
Typical Characteristics

($T_J = 25^\circ\text{C}$ unless otherwise noted)

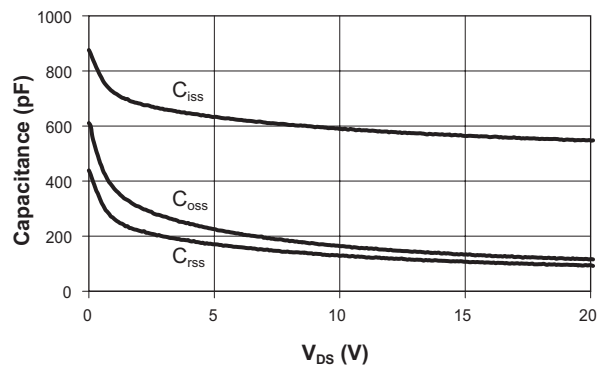
Gate Charge



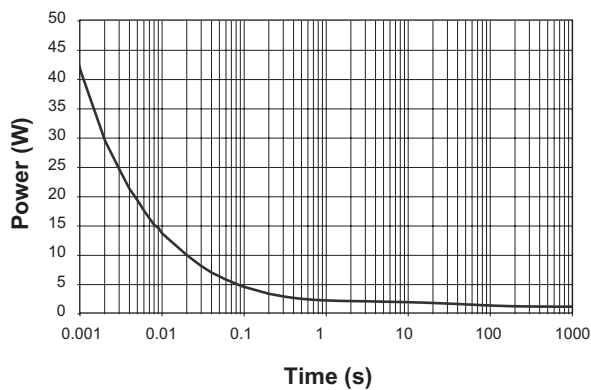
Source-Drain Diode Forward Voltage



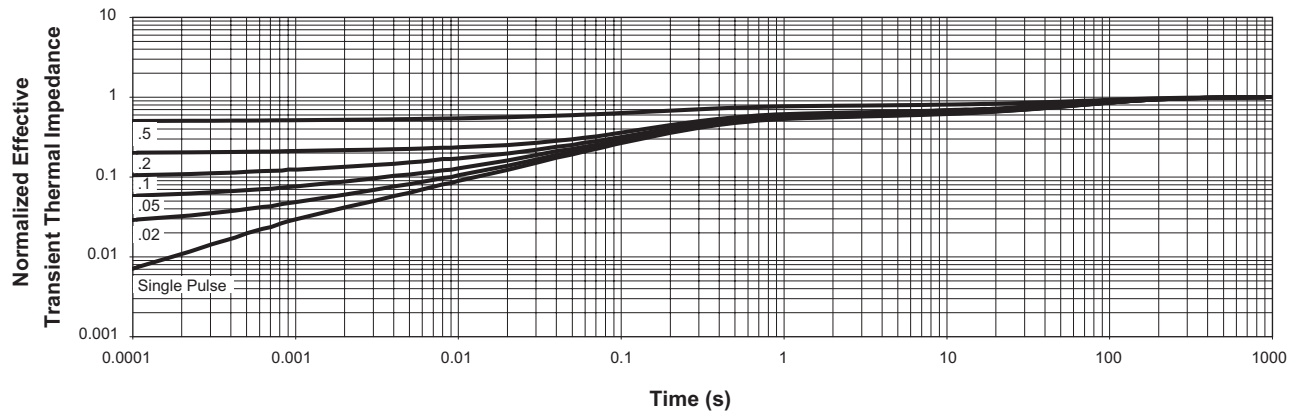
Capacitance



Single Pulse Power, Junction to Ambient



Transient Thermal Response, Junction to Ambient



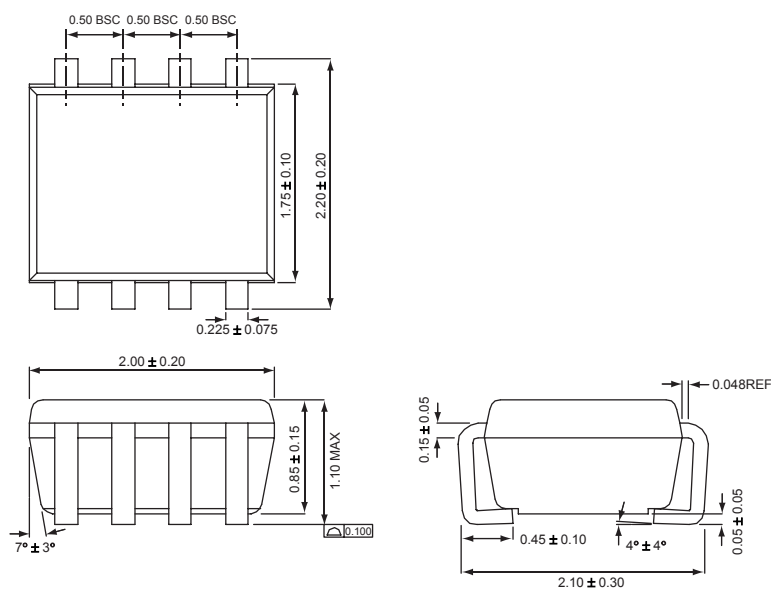
Ordering Information

Package	Marking ¹	Part Number (Tape and Reel)
SC70JW-8	JTXY	AAT8543IJS-T1

Note 1: XY = assembly and date code.

Package Information

SC70JW-8



All dimensions in millimeters.

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